

12V P-Channel Enhancement Mode MOSFET**Description**

The PECN1208MR uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 1.8V. This device is suitable for use as a load switch or in PWM applications.

General Features

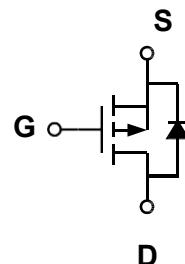
- ◆ $V_{DS} = -12V$, $I_D = -8A$
 $R_{DS(ON)}(\text{Typ.}) = 20m\Omega$ @ $V_{GS} = -2.5V$
 $R_{DS(ON)}(\text{Typ.}) = 15m\Omega$ @ $V_{GS} = -4.5V$
- ◆ High power and current handing capability
- ◆ Lead free product is acquired
- ◆ Surface mount package

Application

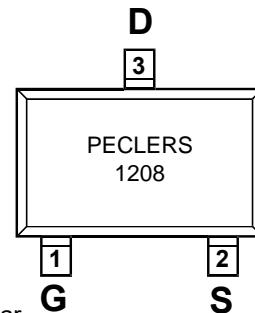
- ◆ PWM applications
- ◆ Load switch

Package

- ◆ SOT-23-3L

**Schematic diagram****Marking and pin assignment**

SOT-23-3L
(TOP VIEW)



PECN: Natlinear
Power 1208

Ordering Information

Part Number	Storage Temperature	Package	Devices Per Reel
PECN1208MR	-55°C to +150°C	SOT-23-3L	3000

Absolute Maximum Ratings (TA=25°C unless otherwise noted)

parameter	symbol	limit	unit
Drain-source voltage	V_{DS}	-12	V
Gate-source voltage	V_{GS}	± 12	V
Continuous Drain Current	I_D	-8	A
		-6	
Pulsed Drain Current ^c	I_{DP}	-32	A
power dissipation ^b	P_D	1.4	W
		0.9	
Junction and Storage Temperature Range	T_J, T_{SGT}	-55—150	°C

Electrical Characteristics (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Typ	Max	Unit
OFF Characteristics						
Drain-source breakdown voltage	BVDSS	V _{GS} =0V, I _D =-250μA	-12	-18	-	V
Zero gate voltage drain current	I _{DSS}	V _{DS} =-12V, V _{GS} =0V	-	-	-1	μA
Gate-body leakage	I _{GSS}	V _{DS} =0V, V _{GS} =±12V	-	-	±100	nA
ON Characteristics						
Gate threshold voltage	V _{GS(th)}	V _{DS} =V _{GS} , I _D =-250μA	-0.4	-0.68	-1.2	V
Drain-source on-state resistance	R _{D(S)ON}	V _{GS} =-4.5V, I _D =-8A	-	15	18	mΩ
		V _{GS} =-2.5V, I _D =-6A	-	20	28	
Forward transconductance	G _{FS}	V _{DS} =-5V, I _D =-8A	-	12	-	S
Dynamic Characteristics						
Input capacitance	C _{iss}	V _{DS} =-6V, V _{GS} =0V f=1.0MHz	-	2700	-	pF
Output capacitance	C _{oss}		-	680	-	
Reverse transfer capacitance	C _{rss}		-	590	-	
Switching Characteristics						
Turn-on delay time	t _{D(ON)}	V _{DD} =-6V I _D =-5A V _{GEN} =-4.5V R _L =1.2ohm R _{GEN} =1ohm	-	11	-	ns
Rise time	tr		-	35	-	
Turn-off delay time	t _{D(OFF)}		-	30	-	
Fall time	tf		-	10	-	
Total gate charge	Q _g	V _{DS} =-6V, I _D =-5A V _{GS} =-4.5V	-	35	-	nC
Gate-source charge	Q _{gs}		-	5	-	
Gate-drain charge	Q _{gd}		-	10	-	
DRAIN-SOURCE DIODE CHARACTERISTICS						
Diode forward voltage	V _{SD}	V _{GS} =0V, I _s =-1.25A	-	-0.81	-1.2	V

Thermal Characteristics

Parameter	Symbol	Typ.	Max.	Unit
Maximum Junction-to-Ambient ^A	t ≤ 10s	R _{θJA}	70	90
Maximum Junction-to-Ambient ^{A D}	Steady-State		100	125
Maximum Junction-to-Lead	Steady-State		62	80

A. The value of R_{θJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25°C. The value in any given application depends on the user's specific board design.

B. The power dissipation PD is based on T_{J(MAX)}=150°C, using ≤ 10s junction-to-ambient thermal resistance.

C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150°C. Ratings are based on low frequency and duty

Typical Performance Characteristics

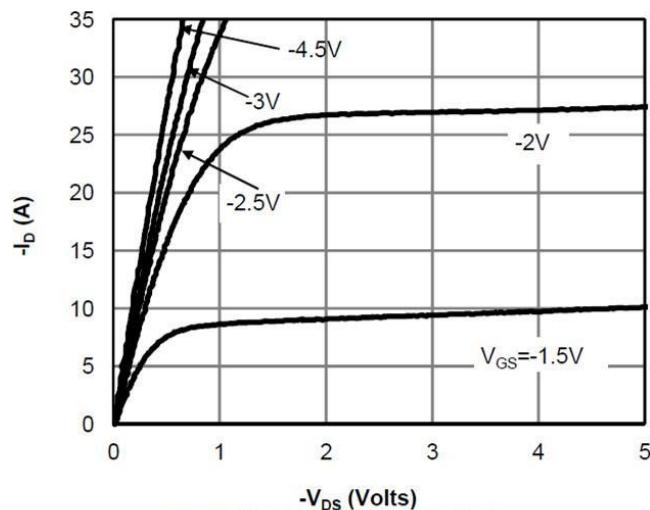


Fig 1: On-Region Characteristics

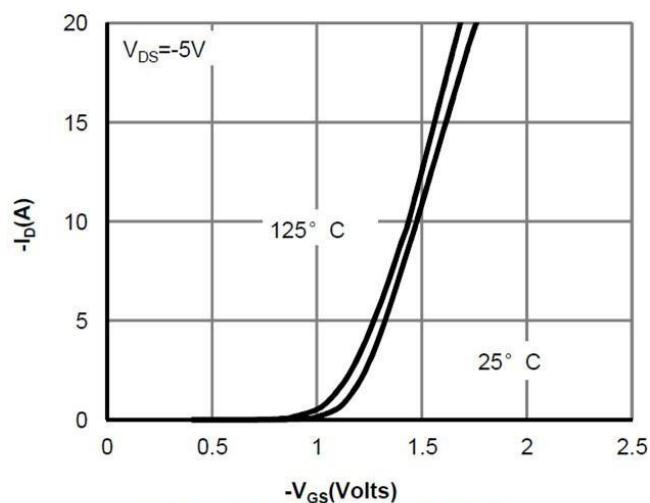


Figure 2: Transfer Characteristics

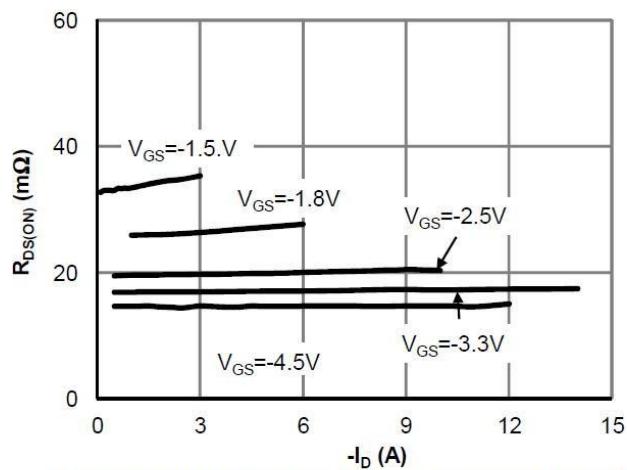


Figure 3: On-Resistance vs. Drain Current and Gate Voltage

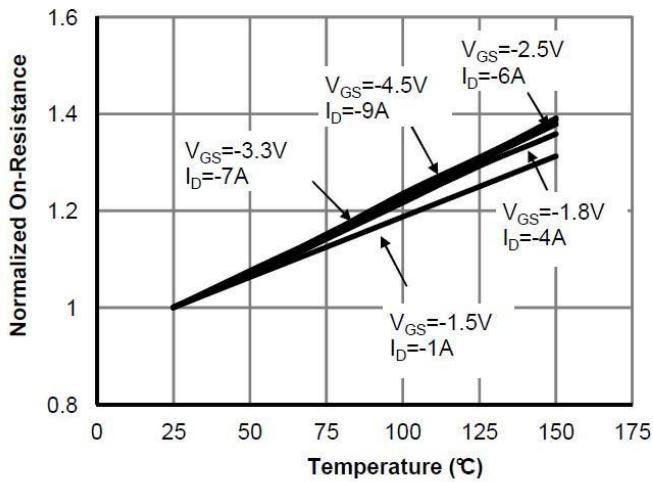


Figure 4: On-Resistance vs. Junction Temperature

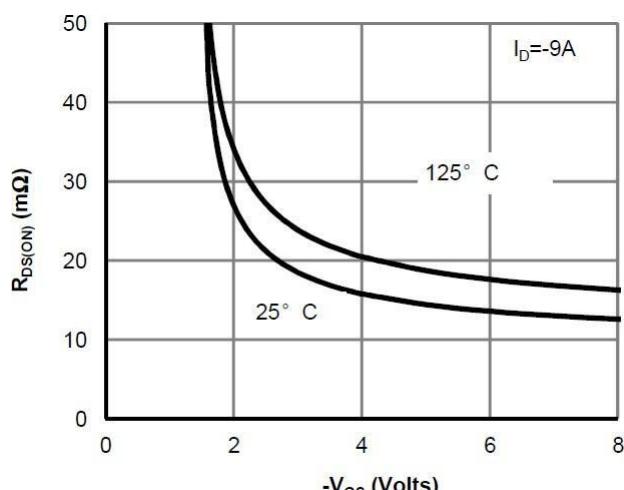


Figure 5: On-Resistance vs. Gate-Source Voltage

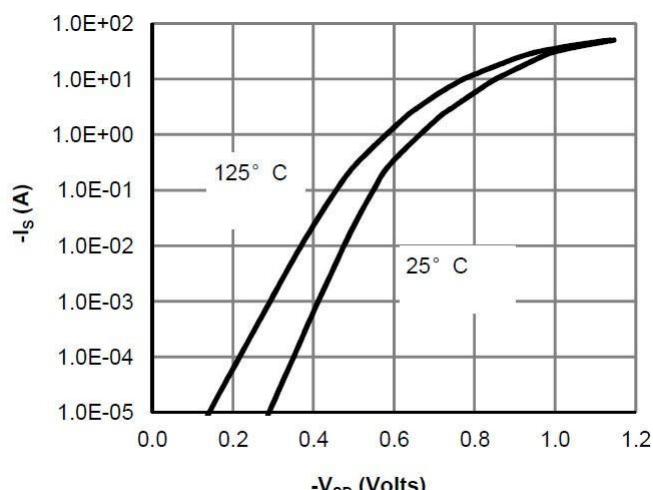


Figure 6: Body-Diode Characteristics

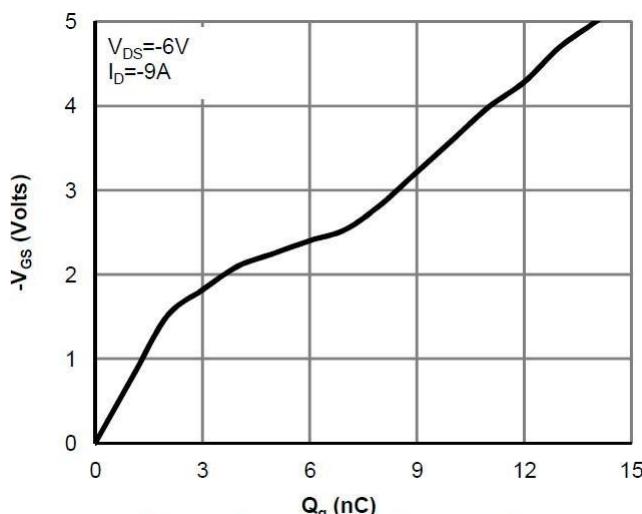


Figure 7: Gate-Charge Characteristics

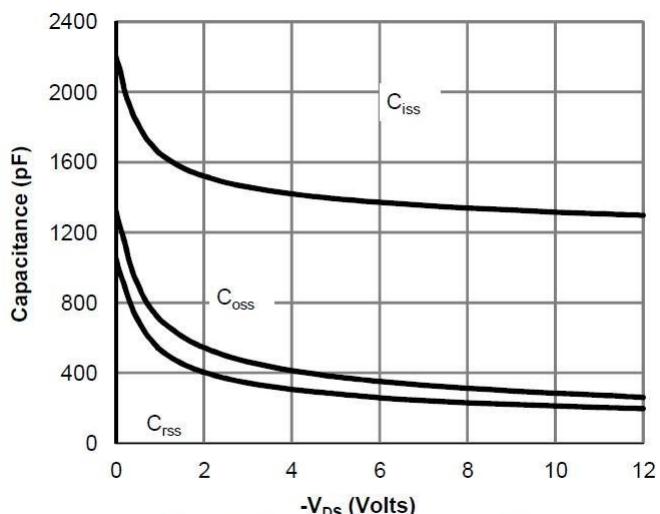


Figure 8: Capacitance Characteristics

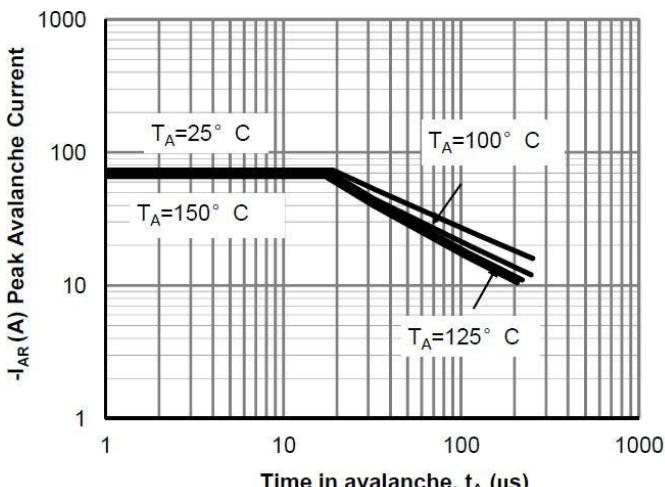


Figure 9: Single Pulse Avalanche capability

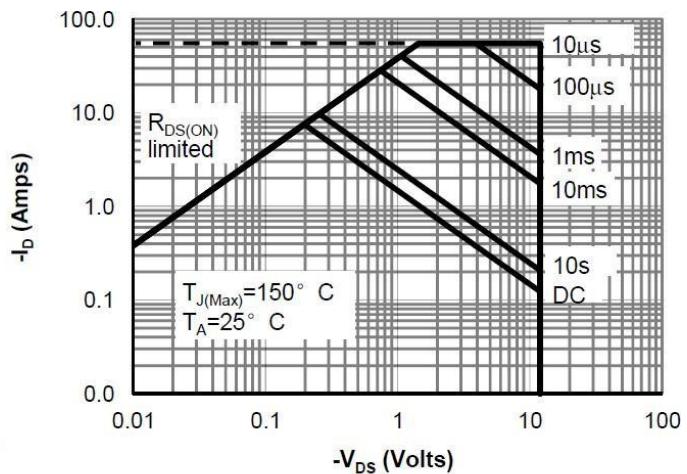


Figure 10: Maximum Forward Biased Safe Operating Area

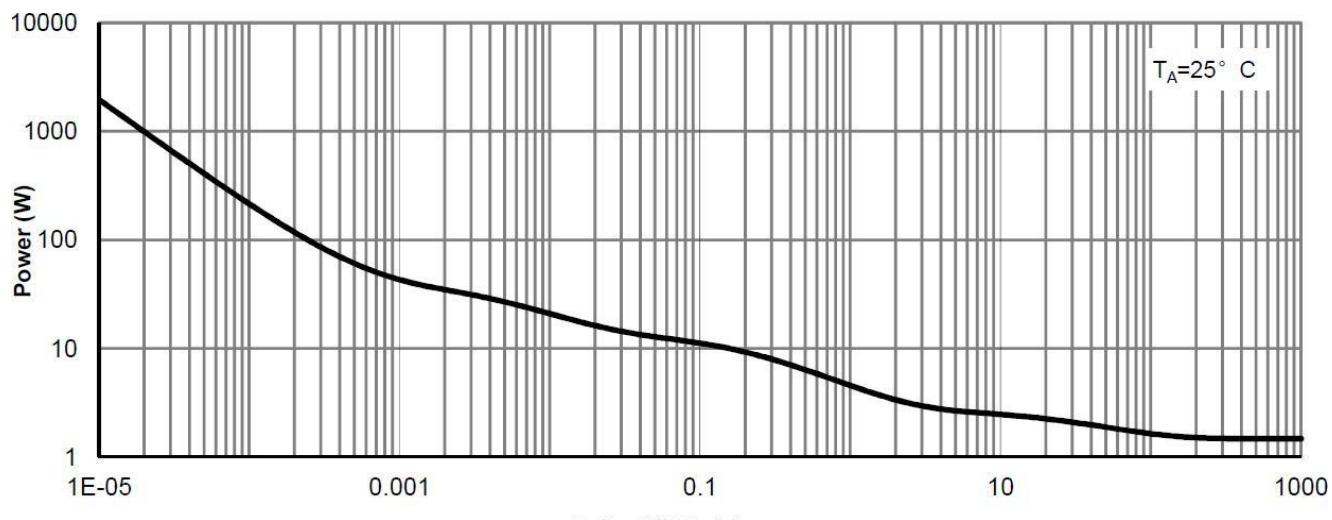


Figure 11: Single Pulse Power Rating Junction-to-Ambient

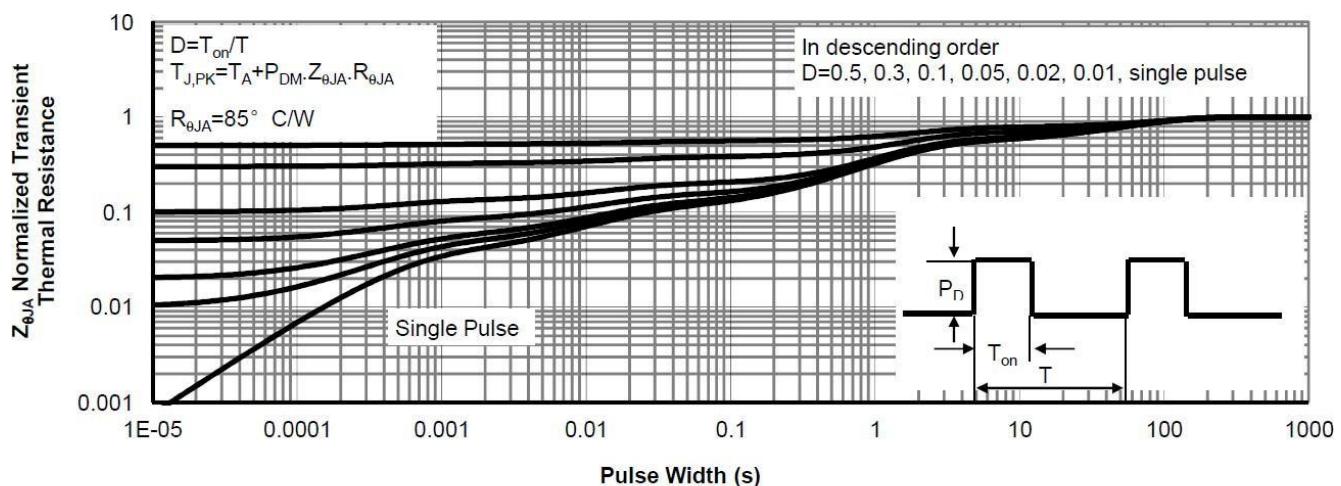
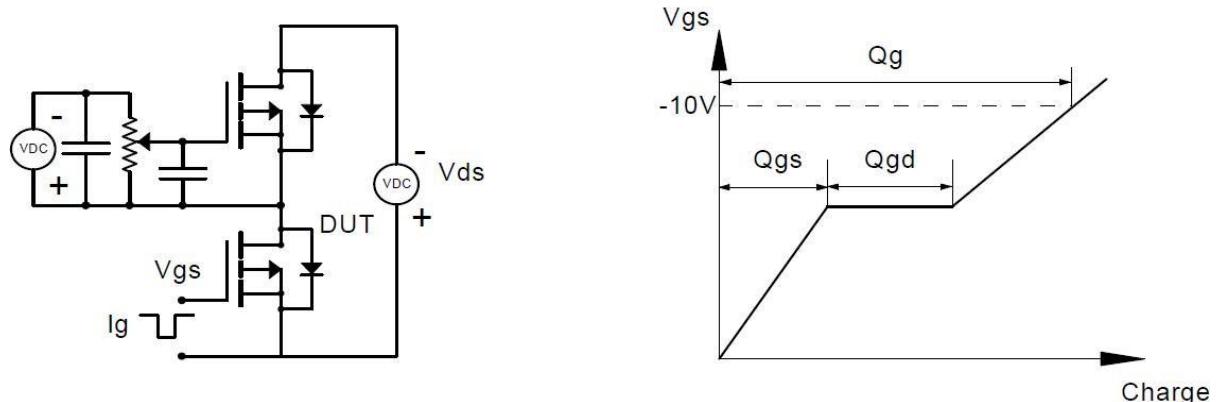
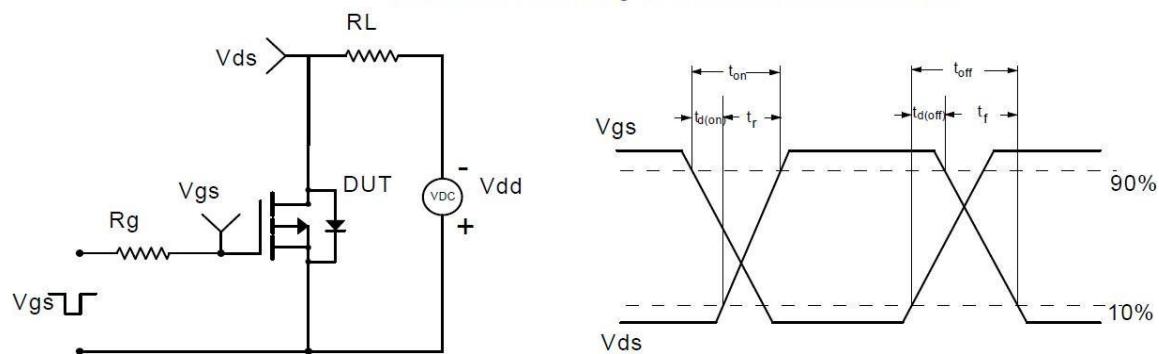


Figure 12: Normalized Maximum Transient Thermal Impedance

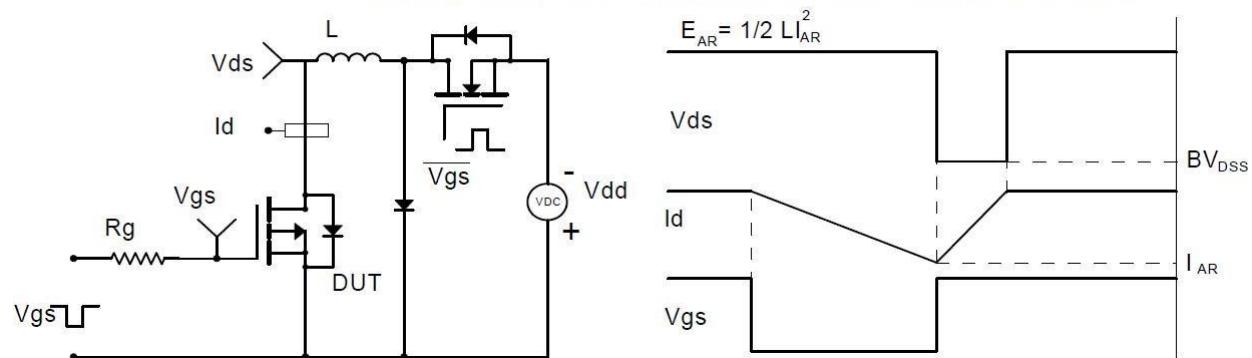
Gate Charge Test Circuit & Waveform



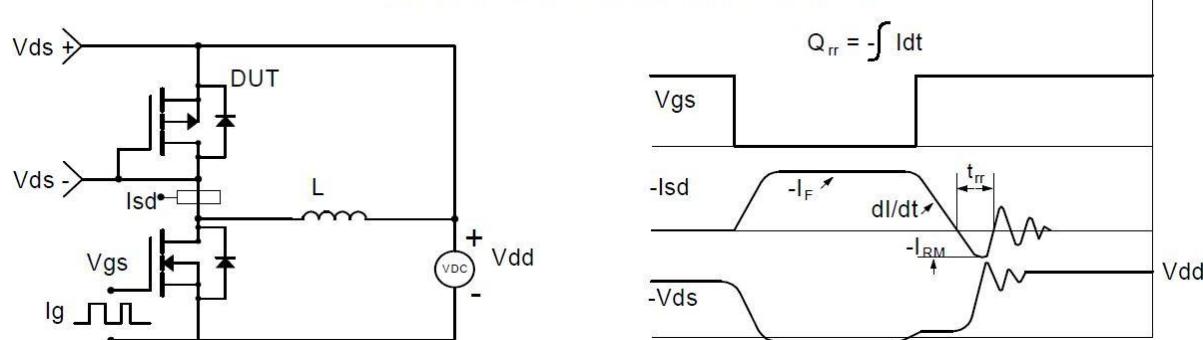
Resistive Switching Test Circuit & Waveforms



Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

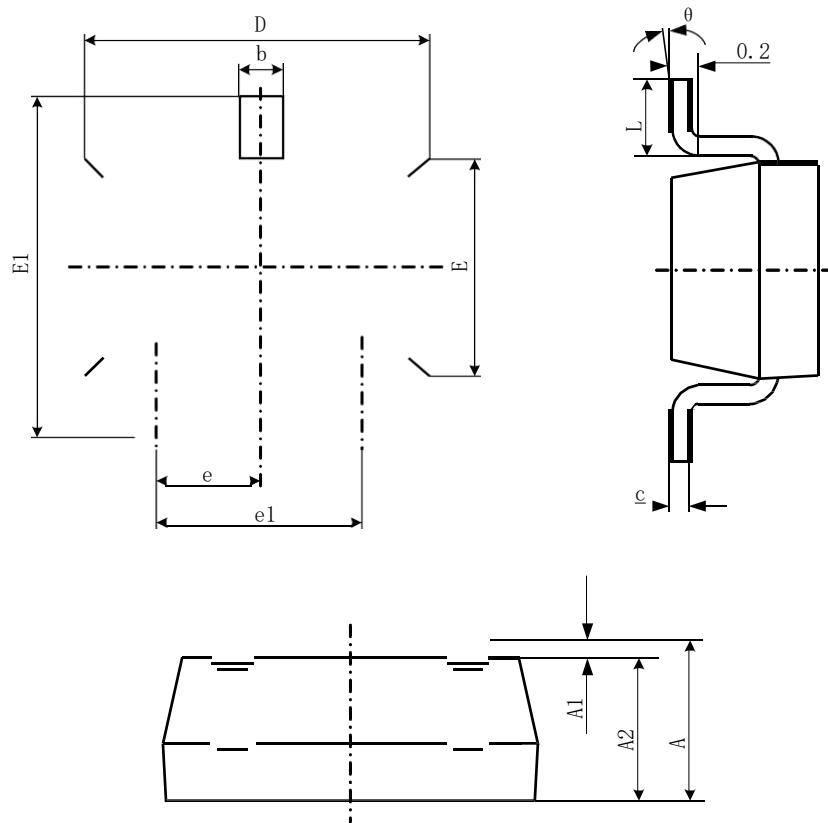


Diode Recovery Test Circuit & Waveforms



Package Information

- SOT-23-3L



Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.050	1.250	0.041	0.049
A1	0.000	0.100	0.000	0.004
A2	1.050	1.150	0.041	0.045
b	0.300	0.500	0.012	0.020
c	0.100	0.200	0.004	0.008
D	2.820	3.020	0.111	0.119
E	1.500	1.700	0.059	0.067
E1	2.650	2.950	0.104	0.116
e	0.950(BSC)		0.037(BSC)	
e1	1.800	2.000	0.071	0.079
L	0.300	0.600	0.012	0.024
θ	0°	8°	0°	8°